

**Notice of References Cited**

Application/Control No.

10/625,919

Applicant(s)/Patent Under  
Reexamination  
WANG ET AL.

Examiner

Jordan Kuhn

Art Unit

2624

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Wang et al.; "Method for recognizing multiple radiation fields in computed radiography", SPIE Vol. 3661, February 1999.
*	V	Barski et al.; "New automatic tone scale method for computed radiography", SPIE Vol. 3335, February 1998.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.